

ST(意法) STAC2932B PDF

深圳创唯电子有限公司

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RF power transistor: HF/VHF/UHF RF power N-channel MOSFETs

Datasheet - production data

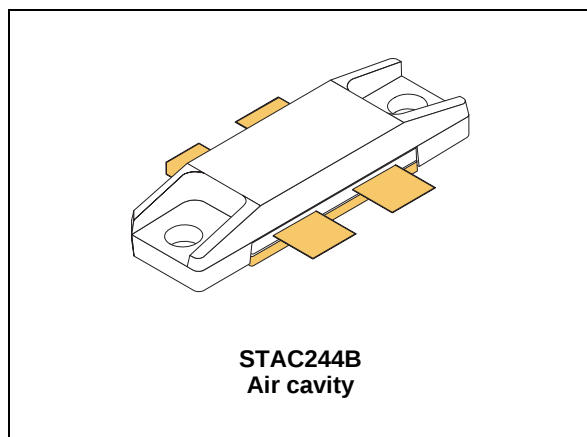
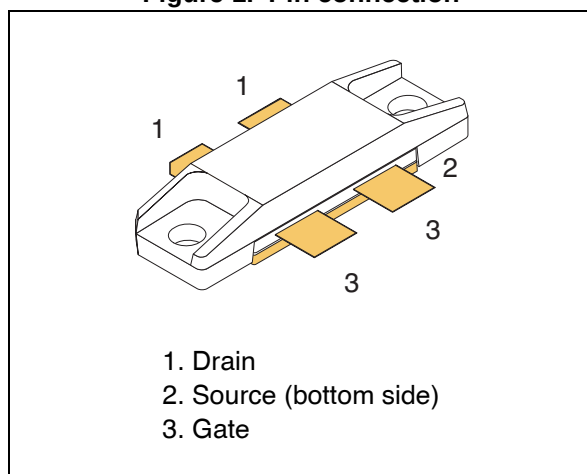


Figure 1. Pin connection



Features

- Gold metallization
- Excellent thermal stability
- Common source push-pull configuration
- $P_{OUT} = 350 \text{ W min. with } 21 \text{ dB gain @ } 175 \text{ MHz}$
- In compliance with the 2002/95/EC European directive

Description

The STAC2942B is a gold metallized N-channel MOS field-effect RF power transistor, intended for use in 50 V DC large signal applications up to 250 MHz.

Table 1. Device summary

Order code	Marking	Package	Packaging
STAC2942BW	STAC2942 ⁽¹⁾	STAC244B	Plastic tray

1. For more details please refer to [Chapter 7: Marking, packing and shipping specifications](#).

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1 Electrical data

1.1 Maximum ratings

Table 2. Absolute maximum ratings ($T_{CASE} = 25\text{ }^{\circ}\text{C}$)

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}^{(1)}$	Drain source voltage	130	V
$V_{DGR}^{(1)}$	Drain-gate voltage ($R_{GS} = 1\text{ M}\Omega$)	130	V
V_{GS}	Gate-source voltage	± 20	V
I_D	Drain current	40	A
P_{DISS}	Power dissipation	625	W
T_J	Max. operating junction temperature	200	$^{\circ}\text{C}$
T_{STG}	Storage temperature	-65 to +150	$^{\circ}\text{C}$

1. $T_J = 150\text{ }^{\circ}\text{C}$

1.2 Thermal data

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Junction - case thermal resistance	0.28	$^{\circ}\text{C/W}$

2 Electrical characteristics

$T_{\text{CASE}} = +25\text{ }^{\circ}\text{C}$

2.1 Static

Table 4. Static (per side)

Symbol	Test conditions		Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}^{(1)}$	$V_{\text{GS}} = 0\text{ V}$	$I_{\text{DS}} = 100\text{ mA}$	130			V
I_{DSS}	$V_{\text{GS}} = 0\text{ V}$	$V_{\text{DS}} = 50\text{ V}$			100	μA
I_{GSS}	$V_{\text{GS}} = 20\text{ V}$	$V_{\text{DS}} = 0\text{ V}$			250	nA
$V_{\text{GS(Q)}}$	$V_{\text{DS}} = 10\text{ V}$	$I_{\text{D}} = 250\text{ mA}$	1.5	2.5	4.0	V
$V_{\text{DS(ON)}}$	$V_{\text{GS}} = 10\text{ V}$	$I_{\text{D}} = 10\text{ A}$			3.0	V
G_{FS}	$V_{\text{DS}} = 10\text{ V}$	$I_{\text{D}} = 5\text{ A}$	5			S
C_{ISS}	$V_{\text{GS}} = 0\text{ V}$ $V_{\text{DS}} = 50\text{ V}$ $f = 1\text{ MHz}$			425		pF
C_{OSS}				202		pF
C_{RSS}				12		pF

1. $T_{\text{J}} = 150\text{ }^{\circ}\text{C}$

2.2 Dynamic

Table 5. Dynamic

Symbol	Test conditions	Min.	Typ.	Max.	Unit
P_{OUT}	$V_{\text{DD}} = 50\text{ V}$, $I_{\text{DQ}} = 2 \times 250\text{ mA}$, $P_{\text{IN}} = 4\text{ W}$, $f = 175\text{ MHz}$	350	450		W
h_{D}	$V_{\text{DD}} = 50\text{ V}$, $I_{\text{DQ}} = 2 \times 250\text{ mA}$, $P_{\text{IN}} = 4\text{ W}$, $f = 175\text{ MHz}$	60	75		%
Load mismatch	$V_{\text{DD}} = 50\text{ V}$; $I_{\text{DQ}} = 2 \times 250\text{ mA}$, $P_{\text{OUT}} = 350\text{ W}$; $f = 175\text{ MHz}$, all phase angles	5:1			VSWR

3 Impedance

Figure 2. Current conventions

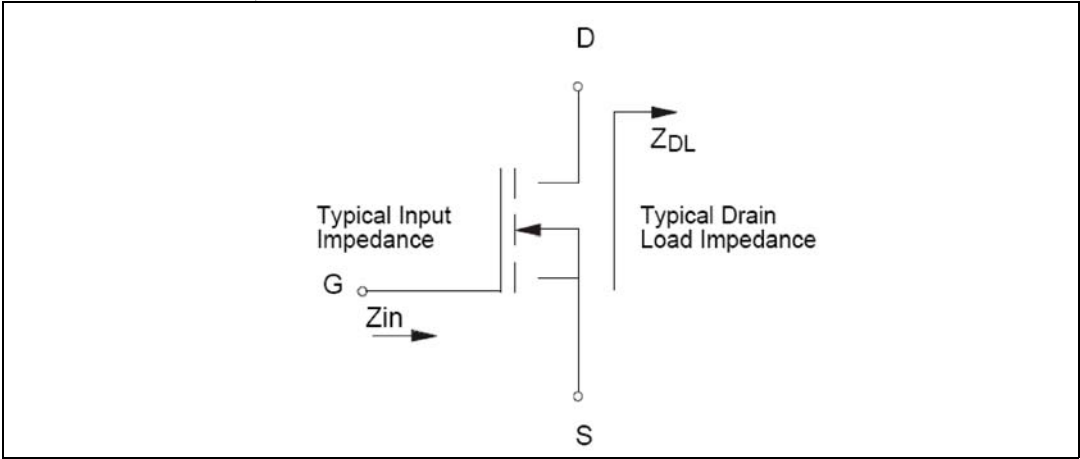


Table 6. Impedance data

Freq. (MHz)	$Z_{IN} (\Omega)$	$Z_{DL} (\Omega)$
175 MHz	$2.0 - j2.0$	$3.5 + j5.2$

Note: Measured gate to gate and drain to drain, respectively.

4 Typical performance

Figure 3. Capacitances vs drain supply voltage Figure 4. Output power vs drain supply voltage

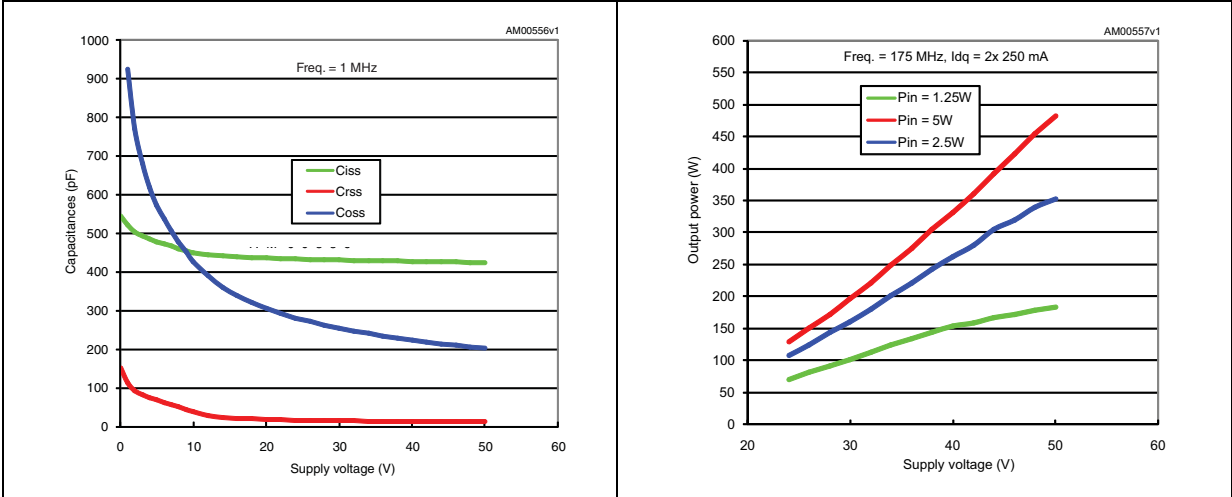


Figure 5. Output power vs gate voltage Figure 6. Output power vs input power

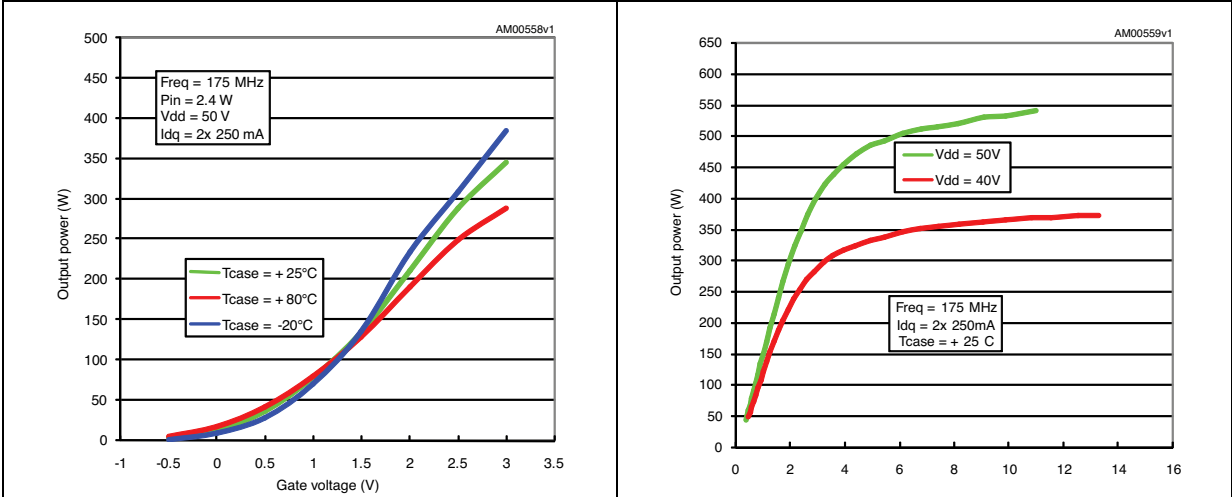


Figure 7. Output power vs input power and case temperature

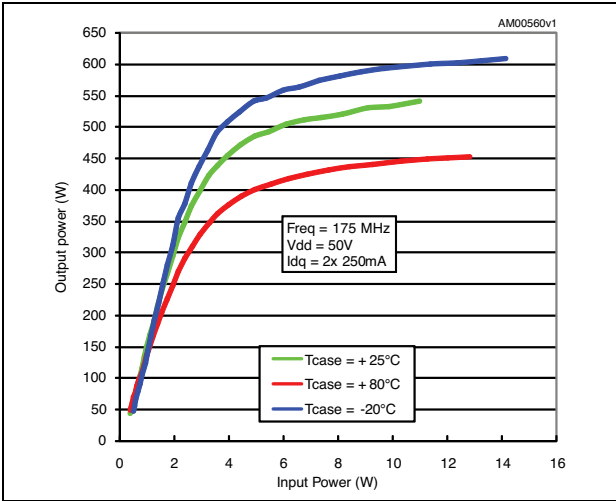


Figure 8. Efficiency vs output power and case temperature

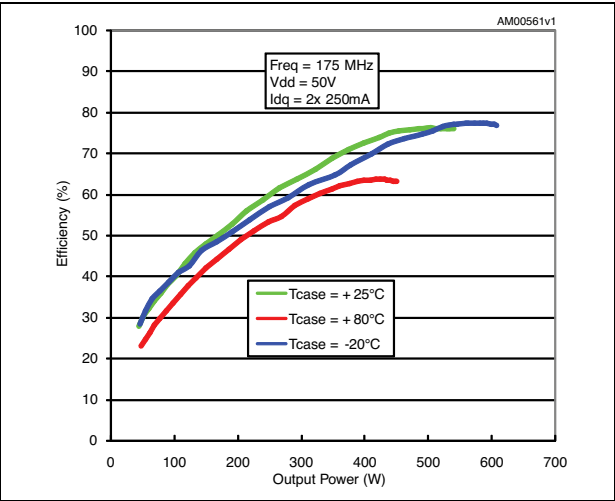


Figure 9. Power gain vs output power and case temperature

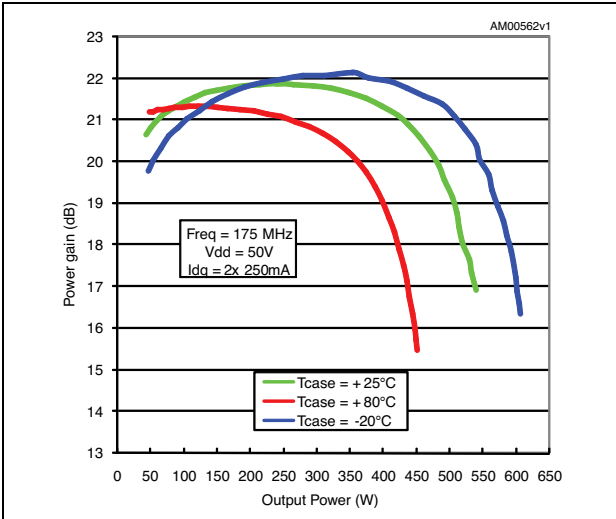


Figure 10. Maximum safe operating area

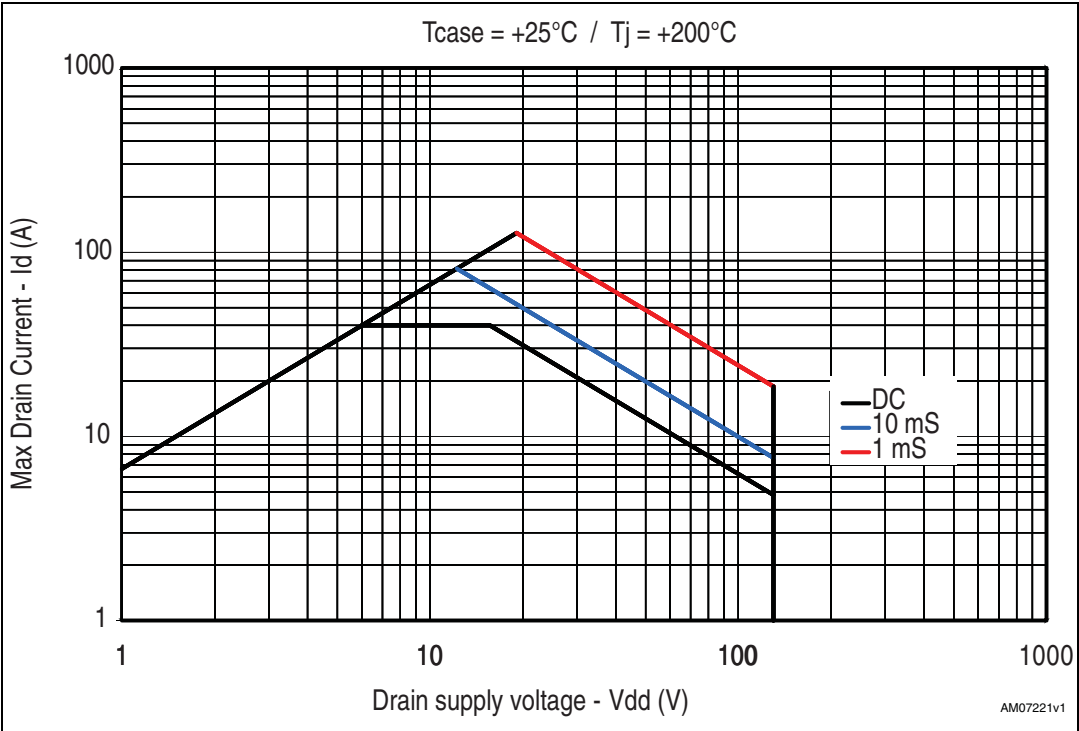


Figure 11. Transient thermal impedance

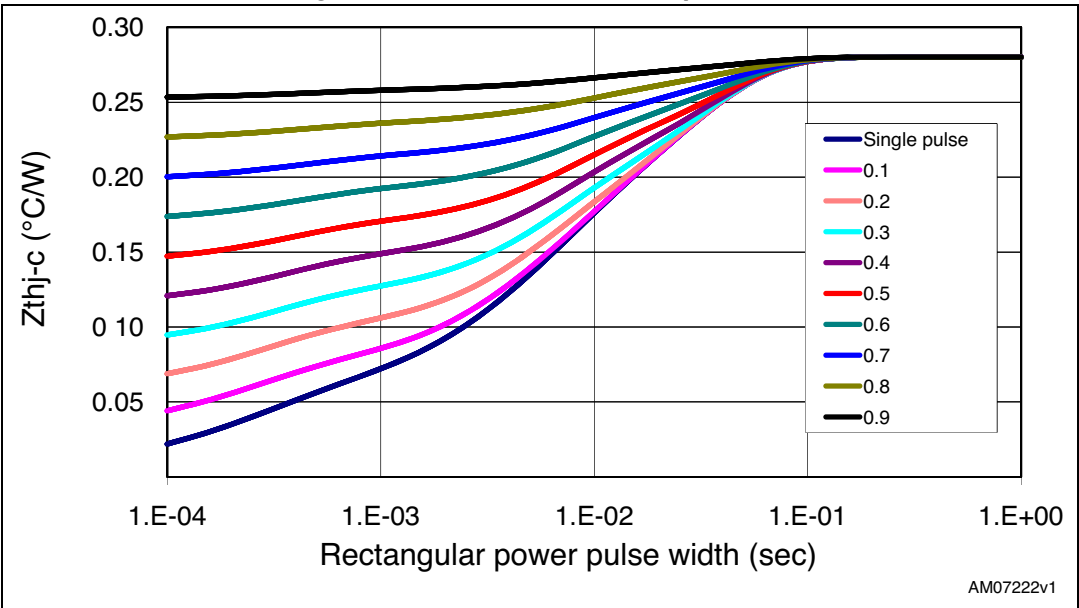
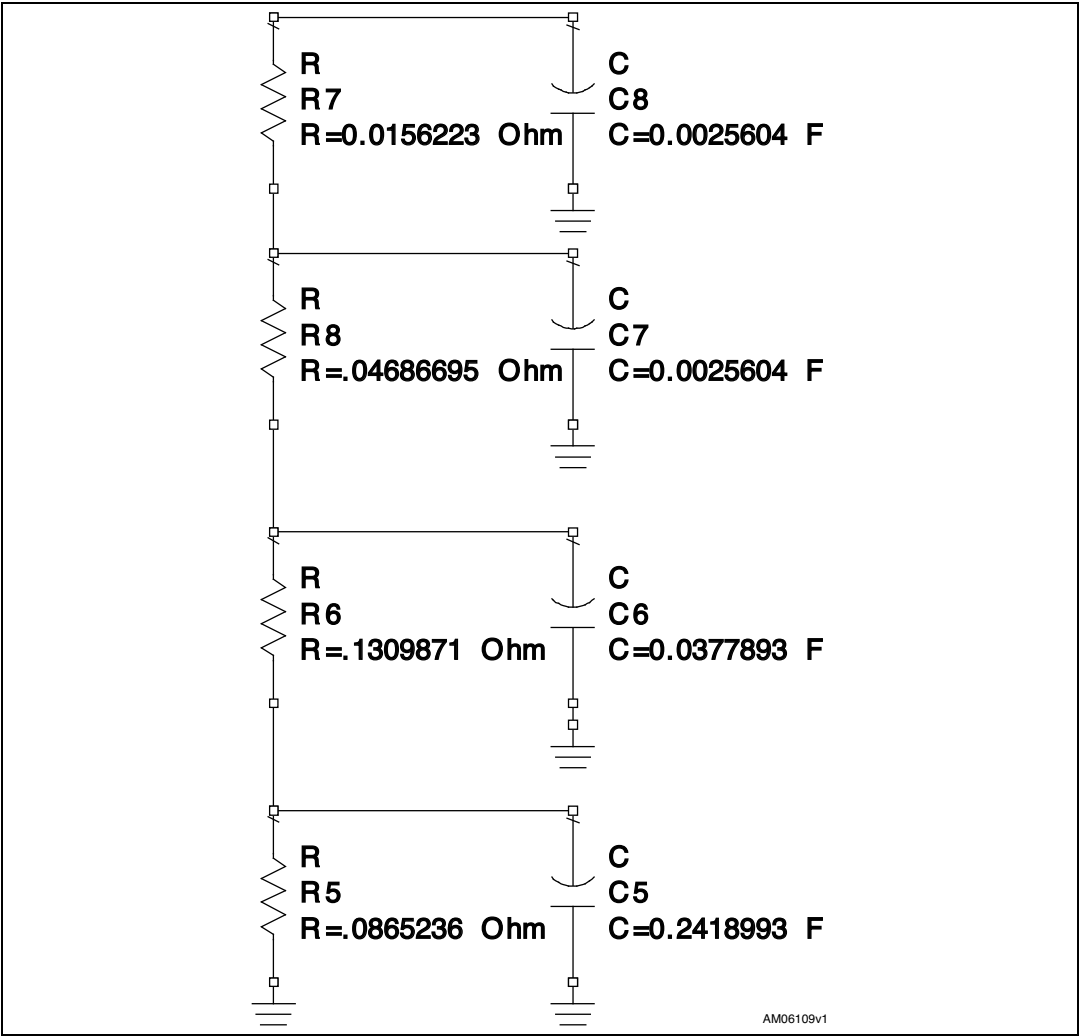


Figure 12. Transient thermal model



5 Test circuit

Figure 13. 175 MHz test circuit schematic (production test circuit)

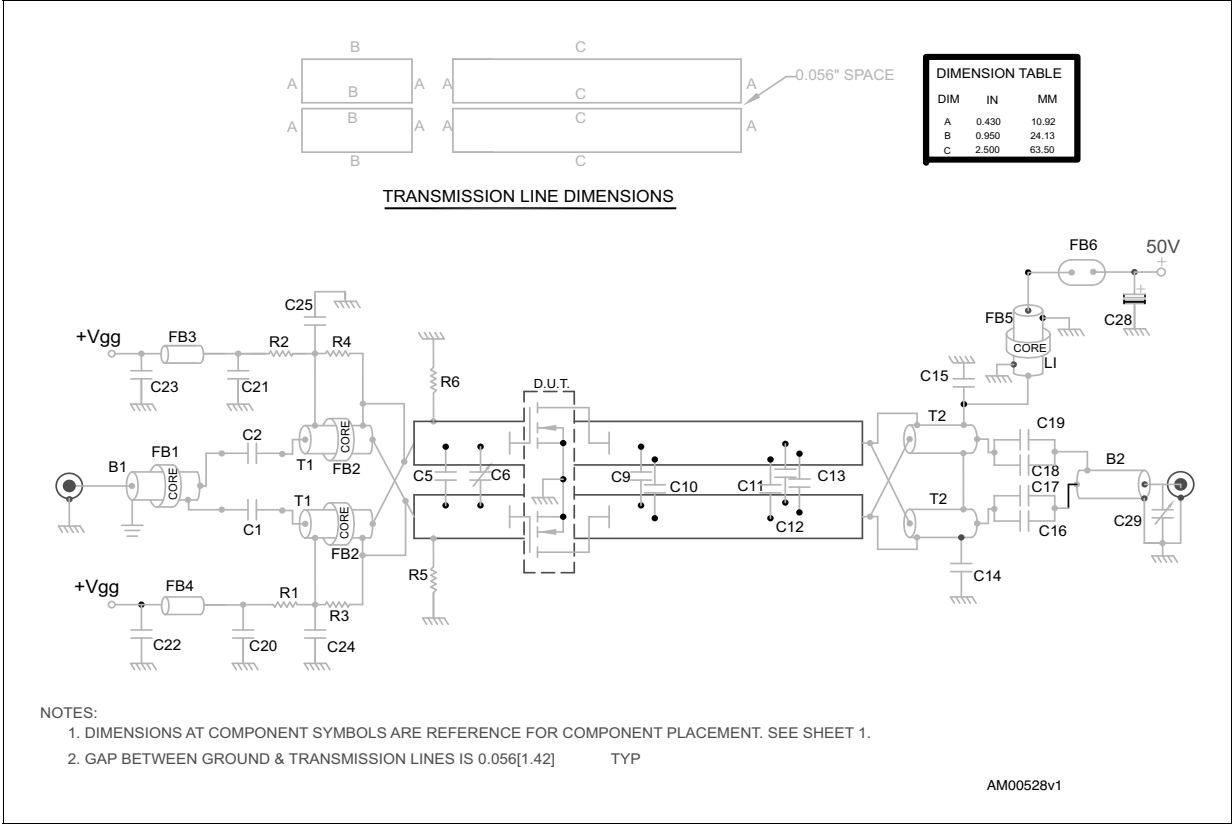


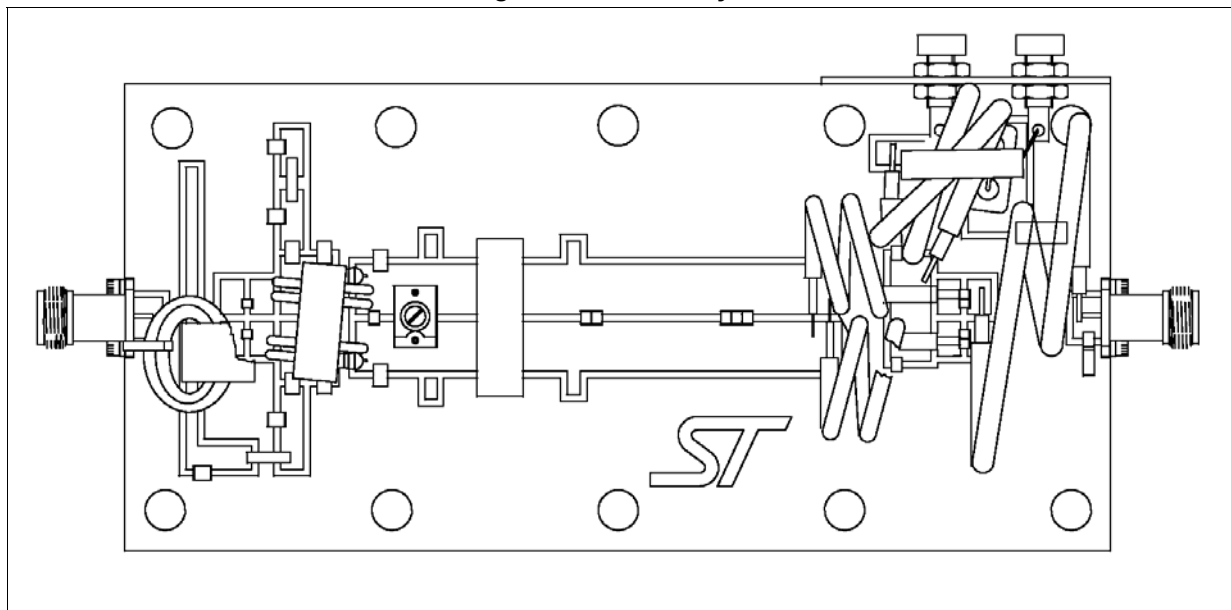
Table 7. 175 MHz test circuit component list

Component	Description
C1, C2, C14, C15, C24, C25	1200 pF ATC 700B chip capacitor
C5	75 pF ATC 100B chip capacitor
C6	ST406 variable capacitor
C9, C10	47 pF ATC 100B chip capacitor
C11, C12, C13	43 pF ATC 100B chip capacitor
C16, C18	470 pF ATC 100B chip capacitor
C17, C19, C20, C21	10,000 pF ATC 200B chip capacitor
C22, C23	.1 μ F 200 V chip capacitor
C28	10 μ F 100 V electrolytic capacitor
C29	.8 - 8 pF variable capacitor
R1, R2, R5, R6	430 Ω , 1/2 W chip resistor

Table 7. 175 MHz test circuit component list (continued)

Component	Description
R3, R4	270 Ω 1/2 W axial lead resistor
B1	RG-316 50 Ω 11.8" through ferrite toroid
B2	RG-142 50 Ω 11.8"
T1	4:1, RG-316 25 Ω , 5.9", 2 turns thru ferrite core
T2	1:4, 25 Ω semi-rigid cable, OD .141", 5.9"
L1	$\lambda/4$ inductor, RG-142 50 Ω , 11.8", 3 turns thru ferrite toroid
FB1,FB5	Ferrite toroid
FB2, FB6	Multi-aperture core
FB3, FB4	Surface mount ferrite bead
PCB	Rogers ultralam 2000, Er 2.55, .060"

Figure 14. Circuit layout



6 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Figure 15. Package dimensions

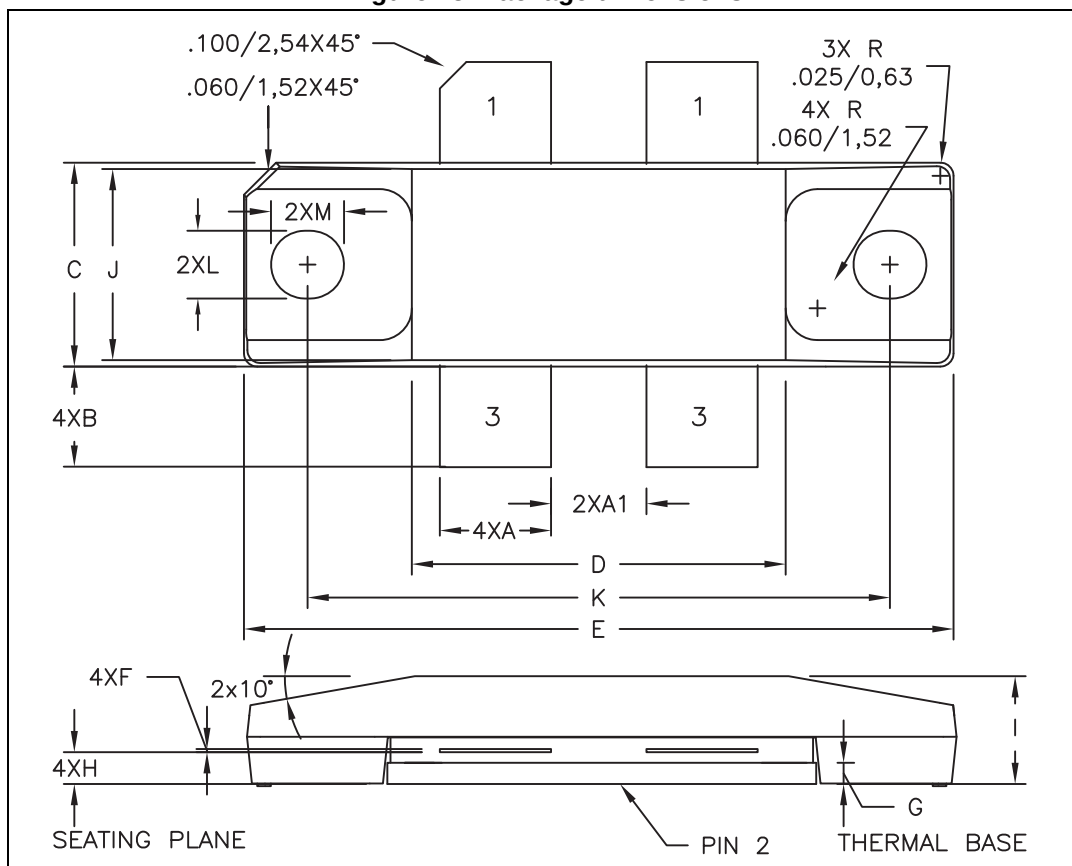


Table 8. STAC244B mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	5.08		5.59
A1	4.32		4.83
B	4.32		5.33
C	9.65		9.91
D	17.78		18.08
E	33.88		34.19
F	0.10		0.15
G		1.02	
H	1.45		1.70
I	4.83		5.33
J	9.27		9.52
K	27.69		28.19
L	3.12	3.23	3.33
M	3.35	3.45	3.56

7 Marking, packing and shipping specifications

Table 9. Packing and shipping specifications

Order code	Packaging	Pcs per tray	Dry pack humidity	Lot code
STAC2942BW	Tray	20	< 10 %	Not mixed

Figure 16. Marking layout

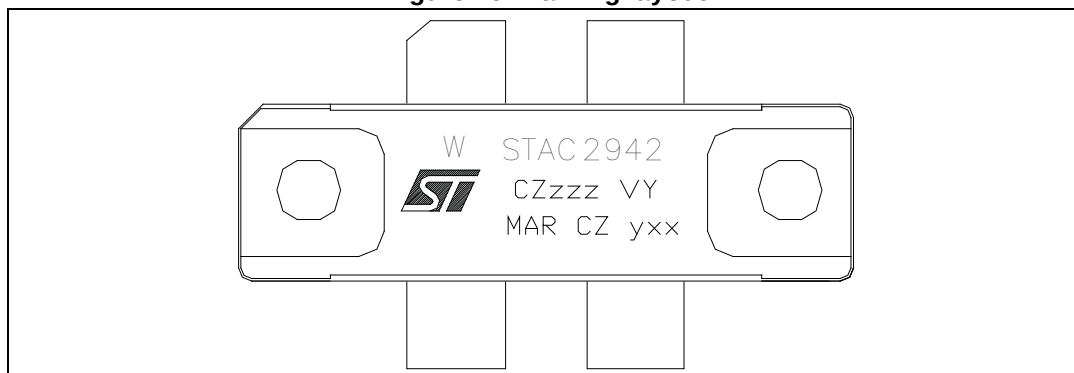


Table 10. Marking specifications

Symbol	Description
W	Wafer process code
CZ	Assembly plant
xxx	Last 3 digits of diffusion lot
VY	Diffusion plant
MAR	Country of origin
CZ	Test and finishing plant
y	Assembly year
yy	Assembly week

8 Revision history

Table 11. Document revision history

Date	Revision	Changes
20-Mar-2009	1	First release.
16-Apr-2010	2	Added Figure 10 , Figure 11 and Figure 12 .
12-Aug-2011	3	Update figures on coverpage and Section 6: Package mechanical data . Inserted Section 7: Marking, packing and shipping specifications .
05-Sep-2011	4	Update L and M dimensions Table 8 on page 13 .
11-Oct-2011	5	Updated order code in Table 1: Device summary and Table 9: Packing and shipping specifications . Updated Table 10: Marking specifications and Figure 16: Marking layout . Modified document title.
17-Jan-2012	6	Updated Table 5: Dynamic new “load mismatch” has been inserted.
27-Jan-2014	7	Modified pin labeling in Figure 1: Pin connection .

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